Search Notes

Applicant(s)/Patent under Reexamination

10/566,968

WAKABAYASHI, HIDEJI

Examiner

Art Unit 2618

Sonny TRINH

SEARCHED				
Subclass	Date	Examiner		
310	10/22/2007	ST		
335	10/22/2007	ST		
317	10/22/2007	ST		
318	10/22/2007	ST		
342	10/22/2007	ST		
278*	10/22/2007	ST		
282*	10/22/2007	ST		
512	10/22/2007	ST		
450,88	10/22/2007	ST		
517	10/22/2007	ST		
452.1	10/22/2007	ST		
452.2	10/22/2007	ST		
	310 335 317 318 342 278* 282* 512 450,88 517 452.1	Subclass Date 310 10/22/2007 335 10/22/2007 317 10/22/2007 318 10/22/2007 342 10/22/2007 278* 10/22/2007 282* 10/22/2007 512 10/22/2007 450,88 10/22/2007 517 10/22/2007 452.1 10/22/2007		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	278	10/22/2007	ST	
370	282	10/22/2007	ST	
455	452.1	10/22/2007	ST	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
U.S. Patent, EPO, JPO, DERWENT, PG-PUB	10/22/2007	ST		
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